

# **TC1263**

# 500 mA, Fixed-Output, CMOS LDO with Shutdown

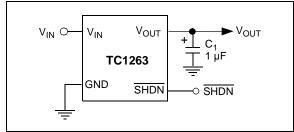
### Features

- Very Low Dropout Voltage
- 500 mA Output Current
- High-Output Voltage Accuracy
- Standard or Custom Output Voltages
- Overcurrent and Overtemperature Protection
- SHDN Input for Active Power Management
- ERROR Output Can Be Used as a Low Battery Detector (SOIC only)

### Applications

- Battery-Operated Systems
- Portable Computers
- Medical Instruments
- Instrumentation
- Cellular/GSM/PHS Phones
- Linear Post-Regulators for SMPS
- Pagers

### **Typical Application**



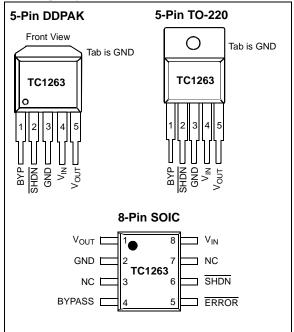
### Description

The TC1263 is a fixed-output, high-accuracy (typically  $\pm 0.5\%$ ) CMOS low dropout regulator. Designed specifically for battery-operated systems, the TC1263's CMOS construction eliminates wasted ground current, significantly extending battery life. Total supply current is typically 80  $\mu$ A at full load (20 to 60 times lower than in bipolar regulators).

TC1263 key features include ultra low noise operation, very low dropout voltage (typically 350 mV at full load) and fast response to step changes in load.

The TC1263 incorporates both overtemperature and overcurrent protection. The TC1263 is stable with an output capacitor of only 1  $\mu$ F and has a maximum output current of 500 mA. It is available in 8-Pin SOIC, 5-Pin TO-220 and 5-Pin DDPAK packages.

### Package Type



# 1.0 ELECTRICAL CHARACTERISTICS

### Absolute Maximum Ratings †

Input Voltage6.5V
Output Voltage (GND – 0.3V) to ( $V_{IN}$ + 0.3V)
Power DissipationInternally Limited (Note 7)
Voltage (max.) on Any Pin: (GND – 0.3V) to ( $V_{IN}$ + 0.3V)
Operating Temperature Range40°C < T_J < +125°C
Storage Temperature65°C to +150°C

**†** Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

# **DC CHARACTERISTICS**

<b>Electrical Specifications:</b> Unless otherwise indicated, $V_{IN} = V_R + 1.0V$ , <b>(Note 1)</b> , $I_L = 100 \ \mu$ A, $C_L = 3.3 \ \mu$ F, SHDN > $V_{IH}$ , $T_A = +25^{\circ}$ C. <b>Boldface</b> type specifications apply for junction temperatures of -40^{\circ}C to +125^{\circ}C.									
Parameters	Sym	Min	Тур	Max	Units	Conditions			
Input Operating Voltage	V <sub>IN</sub>	2.7	_	6.0	V	Note 2			

Input Operating Voltage	V <sub>IN</sub>	2.7	_	6.0	V	Note 2
Maximum Output Current	I <sub>OUTMAX</sub>	500	_	_	mA	
Output Voltage	V <sub>OUT</sub>	V <sub>R</sub> – 2.5%	V <sub>R</sub> ± 0.5%	V <sub>R</sub> + 2.5%	V	Note 1
V <sub>OUT</sub> Temperature Coefficient	$\Delta V_{OUT} / \Delta T$	_	40	_	ppm/°C	Note 3
Line Regulation	$\Delta V_{OUT} / \Delta V_{IN}$	_	0.05	0.35	%	$(V_R + 1V) \le V_{IN} \le 6V$
Load Regulation (Note 4)	$\Delta V_{OUT}/V_{OUT}$	-0.01	0.002	+0.01	%/mA	$I_L = 0.1 \text{ mA to } I_{OUTMAX}$
Dropout Voltage (Note 5)	V <sub>IN</sub> -V <sub>OUT</sub>		20	30	mV	I <sub>L</sub> = 100 μA
			60	130		I <sub>L</sub> = 100 mA
			200	390		I <sub>L</sub> = 300 mA
		_	350	650		I <sub>L</sub> = 500 mA
Supply Current	I <sub>DD</sub>	_	80	130	μA	$\overline{\text{SHDN}} = V_{\text{IH}}, I_{\text{L}} = 0$
Shutdown Supply Current	I <sub>SHDN</sub>	_	0.05	1	μA	SHDN = 0V
Power Supply Rejection Ratio	PSRR	_	64	_	db	F ≤ 1 kHz
Output Short Circuit Current	I <sub>OUTSC</sub>		1200	1400	mA	V <sub>OUT</sub> = 0V
Thermal Regulation	$\Delta V_{OUT} / \Delta P_D$	_	0.04		V/W	Note 6
Output Noise	eN	_	260	_	nV/√Hz	I <sub>L</sub> = I <sub>OUTMAX</sub> , F = 10 kHz

**Note 1:** V<sub>R</sub> is the regulator output voltage setting.

2: The minimum V<sub>IN</sub> has to justify the conditions:  $V_{IN} \ge V_R + V_{DROPOUT}$  and  $V_{IN} \ge 2.7V$  for I<sub>L</sub> = 0.1 mA to I<sub>OUTMAX</sub>.

$$TCV_{OUT} = \frac{(V_{OUTMAX} - V_{OUTMIN}) - 10^{6}}{V_{OUT} \times \Delta T}$$

4: Regulation is measured at a constant junction temperature using low duty-cycle pulse testing. Load regulation is tested over a load range from 0.1 mA to the maximum specified output current. Changes in output voltage due to heating effects are covered by the thermal regulation specification.

5: Dropout voltage is defined as the input-to-output differential at which the output voltage drops 2% below its nominal value measured at a 1.0V differential.

6: Thermal regulation is defined as the change in output voltage at a time T after a change in power dissipation is applied, excluding load or line regulation effects. Specifications are for a current pulse equal to  $I_{LMAX}$  at  $V_{IN}$  = 6V for T = 10 ms.

7: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction-to-air (i.e., T<sub>A</sub>, T<sub>J</sub>, θ<sub>JA</sub>). Exceeding the maximum allowable power dissipation causes the device to initiate thermal shutdown. Please see Section 5.0 "Thermal Considerations" for more details.

3:

# **DC CHARACTERISTICS (CONTINUED)**

<b>Electrical Specifications:</b> Unless otherwise indicated, $V_{IN} = V_R + 1.0V$ , <b>(Note 1)</b> , $I_L = 100 \ \mu$ A, $C_L = 3.3 \ \mu$ F, SHDN > $V_{IH}$ , $T_A = +25^{\circ}$ C. <b>Boldface</b> type specifications apply for junction temperatures of -40°C to +125°C.								
Parameters	Sym	Min	Тур	Max	Units	Conditions		
SHDN Input								
SHDN Input High Threshold	V <sub>IH</sub>	45	_	_	%V <sub>IN</sub>			
SHDN Input Low Threshold	V <sub>IL</sub>	_	_	15	%V <sub>IN</sub>			
ERROR Output (SOIC Only)								
Minimum Operating Voltage	V <sub>MIN</sub>	1.0	_	_	V			
Output Logic Low Voltage	V <sub>OL</sub>	_	_	400	mV	1 mA Flows to ERROR		
ERROR Threshold Voltage	V <sub>TH</sub>	_	0.95 x V <sub>R</sub>	_	V			
ERROR Positive Hysteresis	V <sub>HYS</sub>		50	_	mV			

Note 1:  $V_R$  is the regulator output voltage setting.

3:

2: The minimum V<sub>IN</sub> has to justify the conditions:  $V_{IN} \ge V_R + V_{DROPOUT}$  and  $V_{IN} \ge 2.7V$  for I<sub>L</sub> = 0.1 mA to I<sub>OUTMAX</sub>.

$$TCV_{OUT} = \frac{(V_{OUTMAX} - V_{OUTMIN}) - 10^{6}}{V_{OUT} \times \Delta T}$$

4: Regulation is measured at a constant junction temperature using low duty-cycle pulse testing. Load regulation is tested over a load range from 0.1 mA to the maximum specified output current. Changes in output voltage due to heating effects are covered by the thermal regulation specification.

- 5: Dropout voltage is defined as the input-to-output differential at which the output voltage drops 2% below its nominal value measured at a 1.0V differential.
- 6: Thermal regulation is defined as the change in output voltage at a time T after a change in power dissipation is applied, excluding load or line regulation effects. Specifications are for a current pulse equal to  $I_{LMAX}$  at  $V_{IN}$  = 6V for T = 10 ms.
- 7: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction-to-air (i.e., T<sub>A</sub>, T<sub>J</sub>, θ<sub>JA</sub>). Exceeding the maximum allowable power dissipation causes the device to initiate thermal shutdown. Please see Section 5.0 "Thermal Considerations" for more details.

# **TEMPERATURE CHARACTERISTICS**

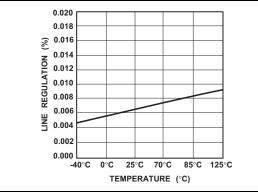
Parameters	Sym	Min	Тур	Max	Units	Conditions
Temperature Ranges						
Specified Temperature Range	T <sub>A</sub>	-40	_	+125	°C	Note 1
Operating Temperature Range	TJ	-40	_	+125	°C	
Storage Temperature Range	T <sub>A</sub>	-65	_	+150	°C	
Thermal Package Resistances						
Thermal Resistance, 5L-DDPAK	$\theta_{JA}$	_	57	_	°C/W	
Thermal Resistance, 5L-TO-220	$\theta_{JA}$	_	71	—	°C/W	
Thermal Resistance, 8L-SOIC	$\theta_{JA}$	_	163	—	°C/W	

Note 1: Operation in this range must not cause  $T_J$  to exceed Maximum Junction Temperature (+125°C).

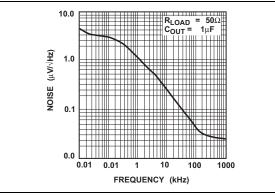
#### 2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

**Note:** Unless otherwise indicated,  $V_{IN} = V_R + 1.0V$ ,  $I_L = 100 \ \mu$ A,  $C_L = 3.3 \ \mu$ F,  $\overline{SHDN} > V_{IH}$ ,  $T_A = +25^{\circ}$ C.

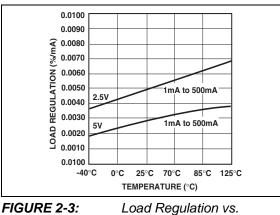




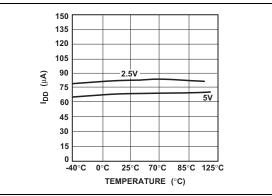




Output Noise vs. Frequency.



Temperature.





I<sub>DD</sub> vs. Temperature.

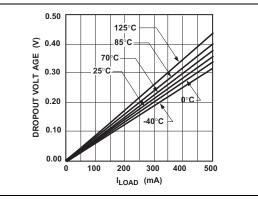
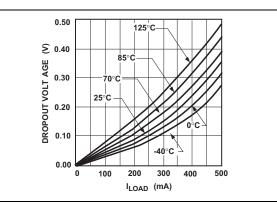
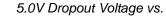


FIGURE 2-5: ILOAD.

2.5V Dropout Voltage vs.







I<sub>LOAD</sub>.

Note: Unless otherwise indicated, V<sub>IN</sub> = V<sub>R</sub> + 1.0V, I<sub>L</sub> = 100  $\mu$ A, C<sub>L</sub> = 3.3  $\mu$ F, SHDN > V<sub>IH</sub>, T<sub>A</sub> = +25°C.

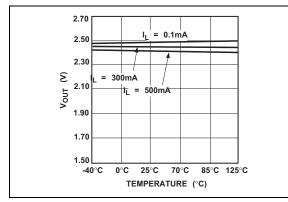


FIGURE 2-7: 2.5V V<sub>OUT</sub> vs. Temperature.

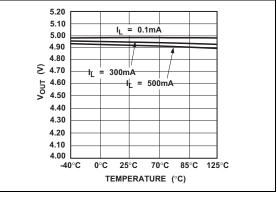


FIGURE 2-8: 5.0V V<sub>OUT</sub> vs. Temperature.

# 3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

### TABLE 3-1: PIN FUNCTION TABLE

Pin No. (8-Pin SOIC)	Pin No. (5-Pin DDPAK) (5-Pin TO-220)	Symbol	Description
1	5	V <sub>OUT</sub>	Regulated voltage output
2	3	GND	Ground terminal
3	—	NC	No connect
4	1	BYPASS	Reference bypass input
5	—	ERROR	Out-of-Regulation Flag (open-drain output).
6	2	SHDN	Shutdown control input
7		NC	No connect
8	4	V <sub>IN</sub>	Unregulated supply input

### 3.1 Regulated Output Voltage (V<sub>OUT</sub>)

V<sub>OUT</sub> is a regulated voltage output.

# 3.2 Ground (GND)

Ground terminal.

### 3.3 Reference Bypass (BYPASS)

Reference bypass input. Connect a 470 pF to the BYPASS input to further reduce output noise.

# 3.4 Out-of-Regulation Flag (ERROR)

Out-of-Regulation Flag (open-drain output).  $\overline{\text{ERROR}}$  goes low when  $V_{\text{OUT}}$  is out-of-tolerance by approximately – 5%.

# 3.5 Shutdown Control (SHDN)

Shutdown control input. The regulator is fully enabled when a logic-high is applied to SHDN. The regulator enters shutdown when a logic-low is applied to this input. During shutdown, output voltage falls to zero and supply current is reduced to  $0.05 \ \mu A$  (typical).

# 3.6 Unregulated Supply (V<sub>IN</sub>)

V<sub>IN</sub> is an unregulated supply input.

# 4.0 DETAILED DESCRIPTION

The TC1263 is a precision, fixed-output LDO. Unlike bipolar regulators, the TC1263's supply current does not increase with load current. In addition,  $V_{OUT}$  remains stable and within regulation over the entire 0 mA to I<sub>LOADMAX</sub> load current range (an important consideration in RTC and CMOS RAM battery back-up applications).

Figure 4-1 shows a typical application circuit.

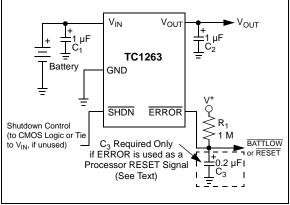


FIGURE 4-1:

Typical Application Circuit.

# 4.1 Output Capacitor

A 1  $\mu$ F (min.) capacitor from V<sub>OUT</sub> to ground is required. The output capacitor should have an Effective Series Eesistance (ESR) greater than  $0.1\Omega$  and less than 5Ω. A 1 µF capacitor should be connected from  $V_{IN}$  to GND if there is either more than 10 inches of wire between the regulator and the AC filter capacitor or a battery is used as the power source. Aluminum electrolytic or tantalum capacitor types can be used. Since many aluminum electrolytic capacitors freeze at approximately -30°C, solid tantalums are recommended for applications operating below -25°C. When operating from sources other than batteries, supply-noise rejection and transient response can be improved by increasing the value of the input and output capacitors, and by employing passive filtering techniques.

# 4.2 ERROR Output

**ERROR** is driven low whenever  $V_{OUT}$  falls out of regulation by more than – 5% (typ.). This condition may be caused by low input voltage, output current limiting or thermal limiting. The ERROR threshold is 5% below rated  $V_{OUT}$ , regardless of the programmed output voltage value (e.g., ERROR =  $V_{OL}$  at 4.75V (typ.) for a 5.0V regulator and 2.85V (typ.) for a 3.0V regulator). ERROR output operation is shown in Figure 4-2.

Note that  $\overline{\text{ERROR}}$  is active when V<sub>OUT</sub> is at or below V<sub>TH</sub>, and inactive when V<sub>OUT</sub> is above V<sub>TH</sub> + V<sub>HYS</sub>.

As shown in Figure 4-1, ERROR can be used as a battery-low flag or as a processor RESET signal (with the addition of timing capacitor  $C_3$ ).  $R_1 \times C_3$  should be chosen to maintain ERROR below  $V_{IH}$  of the processor RESET input for at least 200 ms to allow time for the system to stabilize. Pull-up resistor  $R_1$  can be tied to  $V_{OUT}$ ,  $V_{IN}$  or any other voltage less than ( $V_{IN}$  + 0.3V).

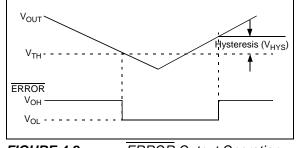


FIGURE 4-2: ERROR OL

ERROR Output Operation.

# 5.0 THERMAL CONSIDERATIONS

### 5.1 Thermal Shutdown

Integrated thermal protection circuitry shuts the regulator off when the die temperature exceeds 160°C. The regulator remains off until the die temperature drops to approximately 150°C.

### 5.2 Power Dissipation

The amount of power the regulator dissipates is primarily a function of input and output voltage and output current. The following equation is used to calculate worst-case actual power dissipation:

### EQUATION 5-1:

 $P_D = (V_{INMAX} - V_{OUTMIN})I_{LOADMAX}$  Where:

P<sub>D</sub> = Worst-case actual power dissipation

 $V_{INMAX}$  = Maximum voltage on  $V_{IN}$ 

V<sub>OUTMIN</sub> = Minimum regulator output voltage

I<sub>LOADMAX</sub> = Maximum output (load) current

The maximum allowable power dissipation (Equation 5-2) is a function of the maximum ambient temperature ( $T_{AMAX}$ ), the maximum allowable die temperature ( $T_{JMAX}$ ) and the thermal resistance from junction-to-air ( $\theta_{JA}$ ).

### **EQUATION 5-2:**

$$P_{DMAX} = \frac{T_{JMAX} - T_{AMAX}}{\theta_{JA}}$$
 Where:

P<sub>D</sub> = Worst-case actual power dissipation

 $V_{INMAX}$  = Maximum voltage on  $V_{IN}$ 

V<sub>OUTMIN</sub> = Minimum regulator output voltage

I<sub>LOADMAX</sub> = Maximum output (load) current

Table 5-1 and Table 5-2 show various values of  $\theta_{JA}$  for the TC1263 package types.

# TABLE 5-1:THERMAL RESISTANCE<br/>GUIDELINES FOR TC1263 IN<br/>8-PIN SOIC PACKAGE

Copper Area (Topside)*	Copper Area (Backside)	Board Area	Thermal Resistance (θ <sub>JA</sub> )
2500 sq mm	2500 sq mm	2500 sq mm	60°C/W
1000 sq mm	2500 sq mm	2500 sq mm	60°C/W
225 sq mm	2500 sq mm	2500 sq mm	68°C/W
100 sq mm	2500 sq mm	2500 sq mm	74°C/W

\* Pin 2 is ground. Device is mounted on top-side.

### TABLE 5-2: THERMAL RESISTANCE GUIDELINES FOR TC1263 IN 5-PIN DDPAK/TO-220 PACKAGE

Copper Area (Topside)*	Copper Area (Backside)	Board Area	Thermal Resistance (θ <sub>JA</sub> )
2500 sq mm	2500 sq mm	2500 sq mm	25°C/W
1000 sq mm	2500 sq mm	2500 sq mm	27°C/W
125 sq mm	2500 sq mm	2500 sq mm	35°C/W

\* Tab of device attached to top-side copper

Equation 5-1 can be used in conjunction with Equation 5-2 to ensure regulator thermal operation is within limits. For example:

Given:

3.3V ± 10% VINMAX VOUTMIN  $2.7V \pm 0.5\%$ = 275 mA **I**LOADMAX = 125°C TJMAX = 95°C TAMAX =  $\theta_{JA}$ 60° C/W (SOIC) =

Find:

1. Actual power dissipation

2. Maximum allowable dissipation

Actual power dissipation:

$$P_D \approx (V_{INMAX} - V_{OUTMIN})I_{LOADMAX}$$
  
 $P_D = (3.3 \times 1.1) - (2.7 \times .995)275 \times 10^{-3}$   
 $P_D = 260 \text{ mW}$ 

Maximum allowable power dissipation:

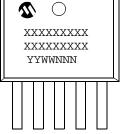
$$P_{DMAX} = \frac{T_{JMAX} - T_{AMAX}}{\theta_{JA}}$$
$$P_{DMAX} = \frac{(125 - 95)}{60}$$
$$P_{DMAX} = 500 \text{ mW}$$

In this example, the TC1263 dissipates a maximum of 260 mW below the allowable limit of 500 mW. In a similar manner, Equation 5-1 and Equation 5-2 can be used to calculate maximum current and/or input voltage limits. For example, the maximum allowable  $V_{\rm IN}$  is found by substituting the maximum allowable power dissipation of 500 mW into Equation 5-1, from which  $V_{\rm INMAX} = 4.6V$ .

# 6.0 PACKAGING INFORMATION

# 6.1 Package Marking Information

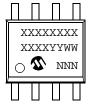
# 5-Lead DDPAK



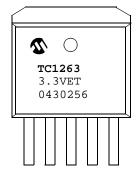
5-Lead TO-220



8-Lead SOIC (150 mil)

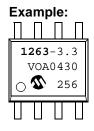


Example:



Example:

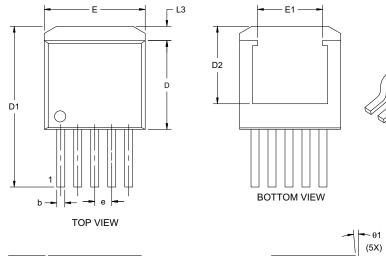


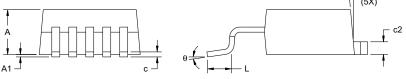


Legen	d: XXX Y YY WW NNN e3 *	Customer-specific information Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code Pb-free JEDEC designator for Matte Tin (Sn) This package is Pb-free. The Pb-free JEDEC designator ((e3)) can be found on the outer packaging for this package.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

# 5-Lead Plastic (ET) (DDPAK)

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging





	Units		INCHES*		N	3		
Dimension	Limits	MIN	NOM	MAX	MIN	MIN NOM		
Number of Pins			5			5		
Pitch	е		.067 BSC			1.70 BSC		
Overall Height	А	.170	.177	.183	4.32	4.50	4.65	
Standoff §	A1	.000	.005	.010	0.00	0.13	0.25	
Overall Width	Е	.385	.398	.410	9.78	10.11	10.41	
Exposed Pad Width	E1		.256 REF					
Molded Package Length	D	.330	.350	.370	8.38	8.89	9.40	
Overall Length	D1	.549	.577	.605	13.94	14.66	15.37	
Exposed Pad Length	D2		.303 REF		7.75 REF			
Lead Thickness	С	.014	.020	.026	0.36	0.51	0.66	
Pad Thickness	c2	.045		.055	1.14		1.40	
Lead Width	b	.026	.032	.037	0.66	0.81	0.94	
Foot Length	L	.068	.089	.110	1.73	2.26	2.79	
Pad Length	L3	.045		.067	1.14		1.70	
Foot Angle	θ			8°			8°	
Mold Draft Angle	θ1	3°		7°	3°		7°	

\*Controlling Parameter

§ Significant Characteristic

Notes:

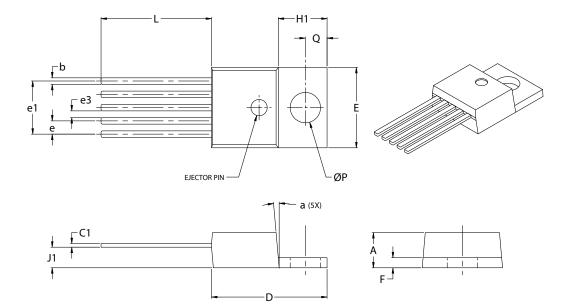
Dimensions D and E do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC equivalent: TO-252

Drawing No. C04-012

# 5-Lead Plastic Transistor Outline (AT) (TO-220)

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	INCHI	ES*	MILLIMETERS		
Dimension Limi	Dimension Limits		MAX	MIN	MAX	
Lead Pitch	е	.060	.072	1.52	1.83	
Overall Lead Centers	e1	.263	.273	6.68	6.93	
Space Between Leads	e3	.030	.040	0.76	1.02	
Overall Height	Α	.160	.190	4.06	4.83	
Overall Width	E	.385	.415	9.78	10.54	
Overall Length	D	.560	.590	14.22	14.99	
Flag Length	H1	.234	.258	5.94	6.55	
Flag Thickness	F	.045	.055	1.14	1.40	
Through Hole Center	Q	.103	.113	2.62	2.87	
Through Hole Diameter	Р	.146	.156	3.71	3.96	
Lead Length	L	.540	.560	13.72	14.22	
Base to Bottom of Lead	J1	.090	.115	2.29	2.92	
Lead Thickness	C1	.014	.022	0.36	0.56	
Lead Width	b	.025	.040	0.64	1.02	
Mold Draft Angle	а	3°	7°	3°	7°	

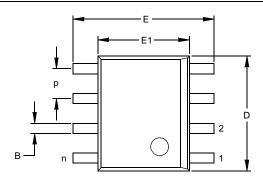
\*Controlling Parameter

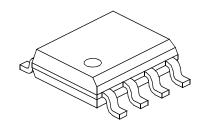
Notes:

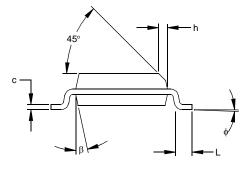
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC equivalent: TO-220 Drawing No. C04-036

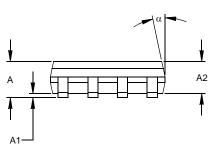
# 8-Lead Plastic Small Outline (SN) – Narrow, 150 mil Body (SOIC)

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging









	Units	INCHES*			N		
Dimensi	on Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.050			1.27	
Overall Height	А	.053	.061	.069	1.35	1.55	1.75
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25
Overall Width	E	.228	.237	.244	5.79	6.02	6.20
Molded Package Width	E1	.146	.154	.157	3.71	3.91	3.99
Overall Length	D	.189	.193	.197	4.80	4.90	5.00
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51
Foot Length	L	.019	.025	.030	0.48	0.62	0.76
Foot Angle	φ	0	4	8	0	4	8
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25
Lead Width	В	.013	.017	.020	0.33	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15
* Controlling Parameter							

\* Controlling Parameter § Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MS-012

Drawing No. C04-057

# APPENDIX A: REVISION HISTORY

### **Revision D (November 2012)**

Added a note to each package outline drawing.

# **Revision C (January 2005)**

The following is the list of modifications:

- 1. Changes to DC Characteristics table
- 2. Added Appendix A: Revision History.

### Revision B (May 2002)

No information for this revision.

# **Revision A (March 2002)**

Original data sheet release.

# TC1263

NOTES:

# **PRODUCT IDENTIFICATION SYSTEM**

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO.	<u>x.x x xx xx</u>			Examples:			
					a)	TC1263-2.5VAT	2.5V LDO, TO-220-5 pkg.
	/oltage	Temperature	Package	Tape and	b)	TC1263-2.8VAT	2.8V LDO, TO-220-5 pkg.
(	Option	Range		Reel	c)	TC1263-3.0VAT	3.0V LDO, TO-220-5 pkg.
					d)	TC1263-3.3VAT	3.3V LDO, TO-220-5 pkg.
Device	TC126	2 Eixed Output CM		S I DO with Shutdown	e)	TC1263-5.0VAT	5.0V LDO, TO-220-5 pkg.
Device	10120	TC1263 Fixed Output CMOS LDO with Shutdown			a)	TC1263-2.5VETTR	1.8V LDO, DDPAK-5 pkg., Tape and Reel
Voltage Option:*	2.5 2.8	$\begin{array}{rcl} 2.8 & = & 2.8 \lor \\ 3.0 & = & 3.0 \lor \\ 3.3 & = & 3.3 \lor \end{array}$			b)	TC1263-2.8VETTR	2.5V LDO, DDPAK-5 pkg., Tape and Reel
					c)	TC1263-3.0VETTR	3.0V LDO, DDPAK-5 pkg., Tape and Reel
	5.0	= 5.0V		d)	TC1263-3.3VETTR	3.3V LDO, DDPAK-5 pkg., Tape and Reel	
		* Other output voltages are available. Please contact your					Tape and Reel
	local M	local Microchip sales office for details.			a)	TC1263-2.5VOA	1.8V LDO, SOIC-8 pkg.
	.,					TC1263-2.5VOATR	1.8V LDO, SOIC-8 pkg., Tape and Reel
Temperature Range	e: V = -	: $V = -40^{\circ}C \text{ to } +125^{\circ}C$				TC1263-2.8VOA	2.5V LDO, SOIC-8 pkg.
Package	AT	– Plantia (TO 2)	Plastic (TO-220), 5-Lead		d)	TC1263-2.8VOATR	2.5V LDO, SOIC-8 pkg., Tape and Reel
Faunaye	ET = Pla ETTR = Pla Tap OA = Pla OATR = Pla			DPAK), 5-Lead	e)	TC1263-3.0VOA	3.0V LDO, SOIC-8 pkg.
		<ul> <li>Plastic Transi</li> <li>Tape and Res</li> </ul>	stic Transistor Outline (D e and Reel	DPAK), 5-Lead,	f)	TC1263-3.0VOATR	3.0V LDO, SOIC-8 pkg., Tape and Reel
			(150 mil Body)		g)	TC1263-3.3VOA	3.3V LDO, SOIC-8 pkg.
				, o-ieau,	h)	TC1263-3.3VOATR	3.3V LDO, SOIC-8 pkg., Tape and Reel
					i)	TC1263-5.0VOA	5.0V LDO, SOIC-8 pkg.

# TC1263

NOTES:

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